

# TRENCH TSPT

# DIM450VHM33-UF000

# Half Bridge IGBT Module

DS6287-1 February 2019 (LN37347)

#### **FEATURES**

- 10µs Short Circuit Withstand
- High Thermal Cycling Capability
- Trench Gate Soft Punch Through IGBT
- Isolated AISiC Base with AIN Substrates

#### **APPLICATIONS**

- High Reliability Inverters
- Motor Controllers
- Traction Drives
- Choppers

The Powerline range of high power modules includes half bridge, chopper, dual, single and bi-directional switch configurations covering voltages from 1200V to 6500V and currents up to 2400A.

The DIM450VHM33-UF000 is a half bridge 3300V, n-channel enhancement mode, insulated gate bipolar transistor (IGBT) module. The IGBT has a wide reverse bias safe operating area (RBSOA) plus 10µs short circuit withstand. This device is optimised for traction drives and other applications requiring high thermal cycling capability.

The module incorporates an electrically isolated base plate and low inductance construction enabling circuit designers to optimise circuit layouts and utilise grounded heat sinks for safety.

#### ORDERING INFORMATION

Order As:

## DIM450VHM33-UF000

Note: When ordering, please use the complete part number

#### **KEY PARAMETERS**

V <sub>CES</sub>		3300V
V <sub>CE(sat)</sub>	* (typ)	2.6V
l <sub>c</sub>	(max)	450A
I <sub>C(PK)</sub>	(max)	900A

<sup>\*</sup> Measured at the auxiliary terminals

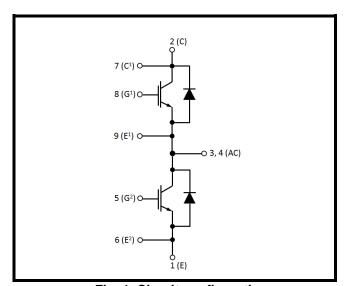


Fig. 1 Circuit configuration

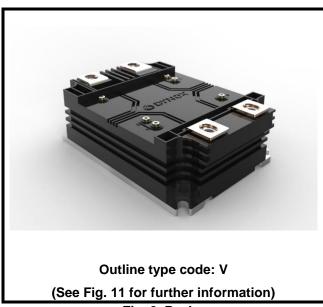


Fig. 2 Package



## **ABSOLUTE MAXIMUM RATINGS**

Stresses above those listed under 'Absolute Maximum Ratings' may cause permanent damage to the device. In extreme conditions, as with all semiconductors, this may include potentially hazardous rupture of the package. Appropriate safety precautions should always be followed. Exposure to Absolute Maximum Ratings may affect device reliability.

T<sub>case</sub> = 25°C unless stated otherwise

Symbol	Parameter	Test Conditions	Max.	Units
V <sub>CES</sub>	Collector-emitter voltage	V <sub>GE</sub> = 0V	3300	V
$V_{GES}$	Gate-emitter voltage		±20	V
I <sub>C</sub>	Continuous collector current	T <sub>case</sub> = 110°C	450	Α
I <sub>C(PK)</sub>	Peak collector current	1ms, T <sub>case</sub> = 140°C	900	Α
P <sub>max</sub>	Max. transistor power dissipation	$T_{case} = 25^{\circ}C, T_{j} = 150^{\circ}C$	5.2	kW
l <sup>2</sup> t	Diode I <sup>2</sup> t value	$V_R = 0$ , $t_p = 10$ ms, $T_j = 150$ °C	80	kA <sup>2</sup> s
V <sub>isol</sub>	Isolation voltage – per module	Commoned terminals to base plate. AC RMS, 1 min, 50Hz	10.2	kV
$Q_{PD}$	Partial discharge – per module	IEC1287, $V_1 = 6900V$ , $V_2 = 5100V$ , 50Hz RMS	10	рC

## THERMAL AND MECHANICAL RATINGS

Internal insulation material:

Baseplate material:

Creepage distance:

Clearance:

CTI (Comparative Tracking Index):

AIN

AISiC

56mm

26mm

>600

Symbol	Parameter	Test Conditions	Min	Тур.	Max	Units
R <sub>th(j-c)</sub>	Thermal resistance – transistor (per switch)	Continuous dissipation - junction to case	-	-	28	°C/kW
R <sub>th(j-c)</sub>	Thermal resistance – diode (per switch)	Continuous dissipation - junction to case	-	-	40	°C/kW
R <sub>th(c-h)</sub>	Thermal resistance – case to heatsink (per module)	Mounting torque 5Nm (with mounting grease)	-	-	24	°C/kW
T <sub>j</sub>	Junction temperature	Transistor	-	-	150	°C
		Diode	-	-	150	°C
T <sub>stg</sub>	Storage temperature range	-	-40	-	150	°C
		Mounting – M6	-	-	5	Nm
	Screw torque	Electrical connections – M4	-	-	2	Nm
		Electrical connections – M8	-	-	10	Nm



## **ELECTRICAL CHARACTERISTICS**

 $T_{case}$  = 25°C unless stated otherwise.

Symbol	Parameter	Test Conditions	Min	Тур	Max	Units
I <sub>CES</sub>	Collector cut-off current	$V_{GE} = 0V$ , $V_{CE} = V_{CES}$			2	mA
		$V_{GE} = 0V$ , $V_{CE} = V_{CES}$ , $T_{case} = 125$ °C			30	mA
		$V_{GE} = 0V$ , $V_{CE} = V_{CES}$ , $T_{case} = 150$ °C			50	mA
I <sub>GES</sub>	Gate leakage current	$V_{GE} = \pm 20V, V_{CE} = 0V$			0.6	μA
$V_{GE(TH)}$	Gate threshold voltage	$I_C = 120$ mA, $V_{GE} = V_{CE}$		6.6		V
		V <sub>GE</sub> = 15V, I <sub>C</sub> = 450A		2.6		V
V <sub>CE(sat)</sub> †	Collector-emitter saturation voltage	$V_{GE} = 15V, I_C = 450A, T_j = 125^{\circ}C$		3.0		V
	G	$V_{GE} = 15V$ , $I_C = 450A$ , $T_j = 150$ °C		3.2		V
I <sub>F</sub>	Diode forward current	DC		450		Α
I <sub>FM</sub>	Diode maximum forward current	t <sub>p</sub> = 1ms		900		Α
	Diode forward voltage	I <sub>F</sub> = 450A		2.1		V
$V_F^{\dagger}$		I <sub>F</sub> = 450A, T <sub>j</sub> = 125°C		2.4		V
		I <sub>F</sub> = 450A, T <sub>j</sub> = 150°C		2.5		V
C <sub>ies</sub>	Input capacitance	V <sub>CE</sub> = 25V, V <sub>GE</sub> = 0V, f = 1MHz		TBD		nF
Qg	Gate charge	±15V		TBD		μC
$C_{res}$	Reverse transfer capacitance	$V_{CE} = 25V, V_{GE} = 0V, f = 1MHz$		TBD		nF
L <sub>M</sub>	Module inductance			24		nΗ
R <sub>INT</sub>	Internal transistor resistance			TBD		μΩ
SC <sub>Data</sub>	Short circuit current, I <sub>SC</sub>	$T_{j} = 150^{\circ}\text{C}, V_{CC} = 2500\text{V}$ $t_{p} \le 10\mu\text{s}, V_{GE} \le 15\text{V}$ $V_{CE  (max)} = V_{CES} - L^{*}x  dI/dt$ IEC 60747-9		1900		А

 $<sup>\ \ ^{+}</sup>$  Measured at the power busbars, not the auxiliary terminals  $^{*}$  L is the circuit inductance +  $L_{M}$ 



## **ELECTRICAL CHARACTERISTICS**

T<sub>case</sub> = 25°C unless stated otherwise

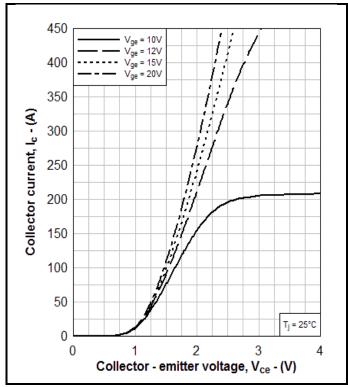
Symbol	Parameter	Test Conditions	Min	Тур.	Max	Units
t <sub>d(off)</sub>	Turn-off delay time	I <sub>C</sub> = 450A		1400		ns
t <sub>f</sub>	Fall time	$V_{GE} = \pm 15V$		520		ns
E <sub>OFF</sub>	Turn-off energy loss	$V_{CE} = 1800V$		1130		mJ
t <sub>d(on)</sub>	Turn-on delay time	$R_{G(ON)} = 3.3\Omega$ $R_{G(OFF)} = 3.3\Omega$		670		ns
t <sub>r</sub>	Rise time	$C_{qe} = 84nF$		120		ns
E <sub>ON</sub>	Turn-on energy loss	L <sub>s</sub> ~ 100nH		430		mJ
$Q_{rr}$	Diode reverse recovery charge	I <sub>F</sub> = 450A		160		μC
I <sub>rr</sub>	Diode reverse recovery current	V <sub>CE</sub> = 1800V		600		Α
E <sub>rec</sub>	Diode reverse recovery energy	$dI_F/dt = 4000A/\mu s$		210		mJ

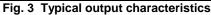
## T<sub>case</sub> = 125°C unless stated otherwise

Symbol	Parameter	Test Conditions	Min	Тур.	Max	Units
t <sub>d(off)</sub>	Turn-off delay time	I <sub>C</sub> = 450A		1450		ns
t <sub>f</sub>	Fall time	$V_{GE} = \pm 15V$		570		ns
E <sub>OFF</sub>	Turn-off energy loss	$V_{CE} = 1800V$		1250		mJ
t <sub>d(on)</sub>	Turn-on delay time	$R_{G(ON)} = 3.3\Omega$ $R_{G(OFF)} = 3.3\Omega$		680		ns
t <sub>r</sub>	Rise time	$C_{qe} = 84nF$		130		ns
E <sub>ON</sub>	Turn-on energy loss	L <sub>S</sub> ~ 100nH		560		mJ
Q <sub>rr</sub>	Diode reverse recovery charge	I <sub>F</sub> = 450A		330		μC
I <sub>rr</sub>	Diode reverse recovery current	V <sub>CE</sub> = 1800V		750		Α
E <sub>rec</sub>	Diode reverse recovery energy	dl <sub>F</sub> /dt = 4000A/µs		360		mJ

# $T_{case}$ = 150°C unless stated otherwise

Symbol	Parameter	Test Conditions	Min	Тур.	Max	Units
t <sub>d(off)</sub>	Turn-off delay time	I <sub>C</sub> = 450A		1500		ns
t <sub>f</sub>	Fall time	$V_{GE} = \pm 15V$		570		ns
E <sub>OFF</sub>	Turn-off energy loss	$V_{CE} = 1800V$		1300		mJ
t <sub>d(on)</sub>	Turn-on delay time	$R_{G(ON)} = 3.3\Omega$ $R_{G(OFF)} = 3.3\Omega$		700		ns
t <sub>r</sub>	Rise time	$C_{qe} = 84nF$		140		ns
E <sub>ON</sub>	Turn-on energy loss	L <sub>s</sub> ~ 100nH		620		mJ
Q <sub>rr</sub>	Diode reverse recovery charge	I <sub>F</sub> = 450A		380		μC
I <sub>rr</sub>	Diode reverse recovery current	V <sub>CE</sub> = 1800V		780		Α
E <sub>rec</sub>	Diode reverse recovery energy	$dI_F/dt = 4000A/\mu s$		400		mJ





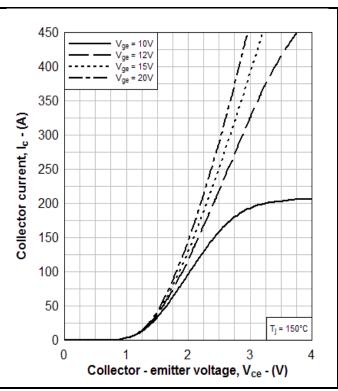


Fig. 4 Typical output characteristics

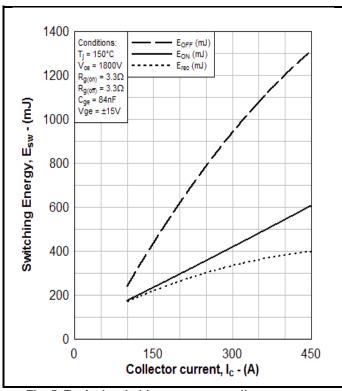


Fig. 5 Typical switching energy vs collector current

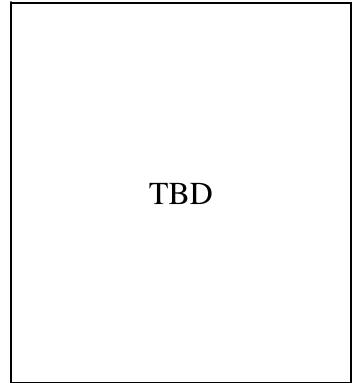


Fig. 6 Typical switching energy vs gate resistance



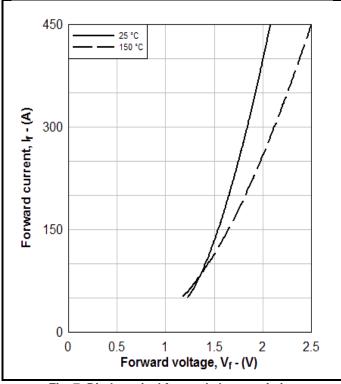


Fig. 7 Diode typical forward characteristics

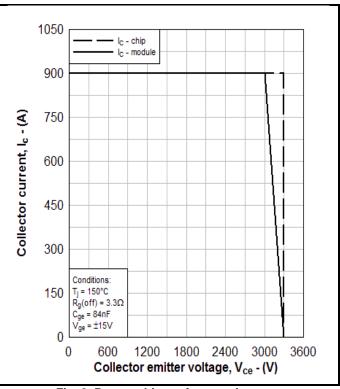


Fig. 8 Reverse bias safe operating area

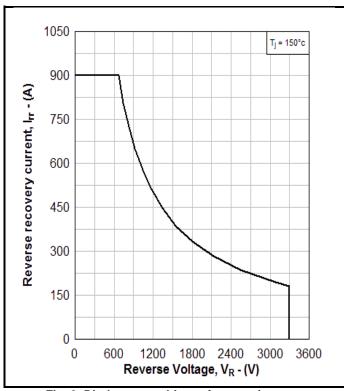


Fig. 9 Diode reverse bias safe operating area

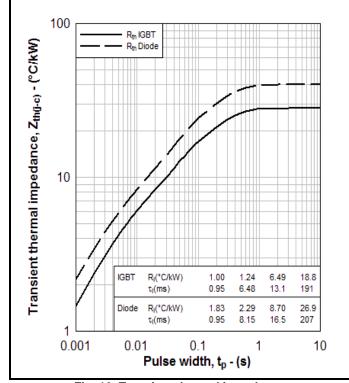


Fig. 10 Transient thermal impedance



## **PACKAGE DETAILS**

For further package information, please visit our website or contact Customer Services. All dimensions in mm, unless stated otherwise.

## DO NOT SCALE.

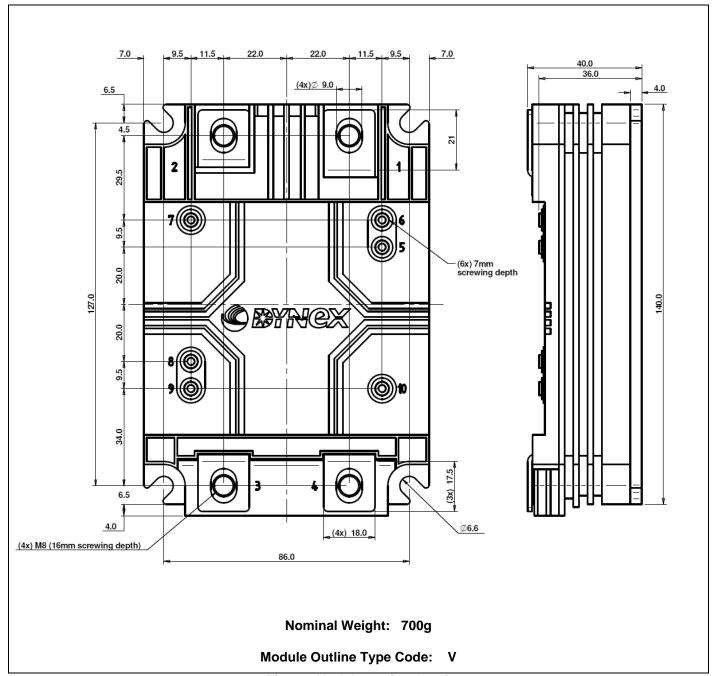


Fig. 11 Module outline drawing



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